

May 6, 2015

Shimon Mizrahi Rainier Commons LLC 918 S. Horton Street, Suite 1018 Seattle, WA 98134

MANAGEMENT | TRAINING | LAB SERVICES www.NVLLABS.com

Subject: Interior Surface Sampling, Exterior Window Pane and Sill Sampling,

Pre and Post-Cleaning Sampling Results - Units 10-200 & 11-200

Site Address: Rainier Commons

3100 Airport Way S

Seattle WA

NVL Project #: 2012-494

Dear Mr. Mizrahi:

Please find below a summary of the testing performed by NVL Laboratories, Inc. (NVL) per Rainier Common's request for sampling and interior surface cleaning oversight and documentation services at specific locations within the 10-200 and 11-200 units at Rainier Commons.

Background

NVL was requested by Rainier Commons to collect both wipe and bulk dust samples at locations that were identified during the course of work by Rainier Commons and EPA. NVL was also requested to provide this report to document the sample locations, testing conditions and provide a summary of the findings along with the actual laboratory analysis reports.

Cleaning Procedure

Once the initial pre-cleaning samples were collected from a surface, Rainier Commons cleaned the surface following a cleaning protocol of HEPA filter vacuuming, then a double wash rinse using both isopropyl alcohol and water as follows:

- 1. Initial vacuuming of the surface with a HEPA filtered vacuum
- 2. Wiping clean the surface with a clean cloth wetted with isopropyl alcohol, which after use was then placed in a bag for proper disposal
- 3. Wiping clean the surface with a clean cloth wetted with clean tap water, which after use was then placed in a bag for proper disposal
- 4. Wiping clean the surface again with a clean cloth wetted with isopropyl alcohol, which after use was then placed in a bag for proper disposal
- 5. Wiping clean the surface again with a clean cloth wetted with clean tap water, which after use was then placed in a bag for proper disposal,

Surfaces were then allowed to air dry prior to re-testing for the residual presence of PCBs and metals, if any.



Sample Collection Methods

Collection for Polychlorinated Biphenyls (PCBs) Surface by "Wipe" Samples Pre & Post Cleaning

Surface samples for the presence of Polychlorinated Biphenyls (PCBs) were collected using a wiping technique using cotton gauze pads wetted with n-hexane which were prepared by NVL in clean glass vials.

Surface areas sampled were measured using a disposable 100 square centimeter (100 cm²) paper template. One template was used per each sample collected and then disposed. The pads were then placed in clean labeled glass jars following sample collection. Clean nitrile gloves were used at each new sample location.

On October 27, 2014, each separate PCB wipe sample was collected over a 400 cm² area. To do this, for each separate sample and using a single hexane wetted cotton gauze pad, the template was placed at 4 different locations within a testing area to collect a total surface area of 400 cm² for both the pre and post cleaning samples. The units for the results were calculated and reported to be per a 100 cm² area.

On subsequent sampling dates, January 12 and 24, 2015, each separate PCB wipe sample was only collected over a 100 cm² area by using a single 100 cm² template. Again, the units for the results were calculated and reported to be per a 100 cm² area.

All sample locations were identified, reviewed and confirmed with Rainier Commons prior to sample collection. The locations of the samples are detailed in the observation section of this report.

Care was taken to assure post-cleaning samples were collected adjacent to, but not from the same sample locations that were earlier used, for the pre-cleaning samples, to control for any additional cleaning effect the initial collection method might have provided.

Collection of Bulk Settled Dust for both PCB and Metal Analysis

- Polychlorinated Biphenyls (PCBs) Window Sill Settled Dust (pre-cleaning)
- Metals Window Sill Settled dust (pre-cleaning)

"Bulk Settled Dust" was collected for laboratory analysis for PCBs and metals using a "brush and collect" method. Dust on the window sill surfaces was collected using separate disposable pieces of clean paper. Sheets of paper were used to brush the settled dust from the sample surface onto a sheet of paper lying adjacent to the sample surface. Dust collected from each sample location was then placed into separate collection bags for analysis.

Bulk Settled Dust Particle Sizing

At the time of sample collection of settled dust on October 27, 2014, a request was also made to have an analysis of the particle sizes. Unfortunately, not enough dust was present to conduct a particle size test, and as a result, this analysis was not conducted. The analytical method, ASTM D422, requires more than 50 grams of fine grain material for the hydrometer phase of the particle size analysis. The total mass of each original dust sample collected which represented most of



the material on the surface was well under 10 grams. There was an insufficient amount of sample material available for valid particle size analysis.

Laboratory Analysis Methods

Information regarding the laboratory analysis methods is provided within the laboratory reports. In general, the methods are summarized as:

- <u>PCB Analysis:</u> EPA Method 8082A Polychlorinated Byphenyls (PCBs) by Gas Chromatography.
- Metal Analysis: EPA Method 3051/6010C: Microwave Assisted Acid Digestion of Sediments, Sludges, Soils, and Oil. Metals previously determined to be present in abrasive blasting medium were selected to be tested in the analysis. The metals selected were Chromium, Copper, Nickel and Zinc.

Sampling & Test Results

All samples were collected by Dave Leonard, CIH.

The following tables summarize the testing information and laboratory results:

	TABLE 1 Polychlorinated Biphenyls (PCBs) SURFACE "WIPE" SAMPLES PRE & POST CLEANING								
Building	Sample Location Description	PRE- Cleaning Abbreviated Sample # (sample date) Total PCB Concentration (µg/100 cm²)	POST- Cleaning Abbreviated Sample # (sample date) Total PCB Concentration (µg/100 cm²)	Reporting Limit (RL) (µg/100 cm²)	Clearance confirmation Post- cleaning: Total PCB Concentration found < 10 µg/100 cm ²				
Bldg. 11- 200	Inside West Elevation South Window Inside Pane Surface of "sound proofing glass" Center Surface	A-1 = ND (10-27-14)	A-2* = ND (10-27-14) A = ND (1-12-15)	0.5	YES				
Bldg. 11- 200	Inside West Elevation South Window Inside Pane Surface of "structural glass" Center Pane	B-1* = ND (10-27-14)	B-2* = ND (10-27-14) B = ND (1-12-15)	0.5	YES				



Bldg. 11- 200	South <u>Interstitial</u> <u>Window Sill</u>	Wipe sample not collected on 10-27-14. Rather, a bulk sample was collected due to visible debris. See results in tables 2 & 3.	C = 14.6 (1-12-15) (Aroclor 1254 = 9.0) (Aroclor 1260 = 5.6) B = 4.7 (1-24-15) (Aroclor 1254 = 2.6) (Aroclor 1260 = 2.1)	0.5	YES
Bldg. 11- 200	Inside West Elevation North Window Inside Pane Surface of "sound proofing glass" Center Surface	C-1* = ND (10-27-14)	C-2* = ND (10-27-14) D = ND (1-12-15)	0.5	YES
Bldg. 11- 200	Inside West Elevation North Window Inside Pane Surface of "structural glass" Center Pane	D-1* = ND (10-27-14)	D-2* = ND (10-27-14) E = ND (1-12-15)	0.5	YES
Bldg. 11- 200	North <u>Interstitial</u> <u>Window Sill</u>	Wipe sample not collected on 10-27-14. Rather, a bulk sample was collected due to visible debris. See results in tables 2 & 3.	F = 7.9 (1-12-15) (Aroclor 1254 = 5.2) (Aroclor 1260 = 2.7) A = 13.2 (1-24-15) (Aroclor 1254 = 8.0) (Aroclor 1260 = 5.2)		YES**
Bldg. 10- 200	<u>Floor</u> in front of windows – before cleaning	E-1* = 27.7 (10-27-14) (Aroclor 1254 = 10.4) (Aroclor 1260 = 17.3)	E-2* = 2.1 (10-27-14) (Aroclor 1254 = 1.1) (Aroclor 1260 = 1.0)	E-1 = 5.0*** E-2 = 0.5	NA
Sample Sets	All Field Blanks	-	G = ND (1-12-15) C = ND (1-24-15)	0.5	NA

ND = None Detected (Less than RL)

RL = Reporting Limit of Instrument

NA = Not Applicable

^{*=} Area Sampled = 400 cm², Result Units = 100 cm²

**= Total PCB Concentration found < 10 µg/100 cm² after cleaning on 1-12-15

^{*** =} RL for Sample E-1 = $5.0 \,\mu\text{g}/100 \,\text{cm}^2$ due to higher level of PCBs present in sample, the sample required a X10 dilution which created a x10 change in the reporting limit.



TABLE 2 Polychlorinated Biphenyls (PCBs)

INTERSTITIAL WINDOW SILL FRAMING SETTLED DUST (PRE-CLEANING) NVL Batch No: 1419129

Sample #	102714-BULK-1	102714-BULK-2
Building	Bldg. 11-200	Bldg. 11-200
Sample Location	Interstitial Window	Interstitial Window
Description	Sill South Window	Sill North Window
Description	West Elevation	West Elevation
Results in:	ppm (mg/kg)	ppm (mg/kg)
Aroclor 1016	ND	ND
Aroclor 1221	ND	ND
Aroclor 1232	ND	ND
Aroclor 1242	ND	ND
Aroclor 1248	ND	ND
Aroclor 1254	1,100.0	4,200.0
Aroclor 1260	2,000.0	7,600.0
TOTAL PCB	3,100.0	11,800.0
Reporting Limit	220.0	1,400.0
ND Name Detecto	al (Laga than DL)	

ND = None Detected (Less than RL)

RL = Reporting Limit of Instrument

TABLE 3 METALS

INTERSTITIAL WINDOW SILL FRAMING SETTLED DUST (PRE-CLEANING) NVL Batch No: 1419125

Sample #	102714-BULK-1	102714-BULK-2
Building	Bldg. 11-200	Bldg. 11-200
Sample Location	Interstitial Window	Interstitial Window
Description	Sill South Window	Sill North Window
Description	West Elevation	West Elevation
Results in:	ppm (mg/kg)	ppm (mg/kg)
Chromium	130.0	130.0
Copper	89.0	80.0
Nickel	ND	ND
NICKEI	<66.0	<19.0
Zinc	64,000	32,000
Reporting Limit	66.0	19.0

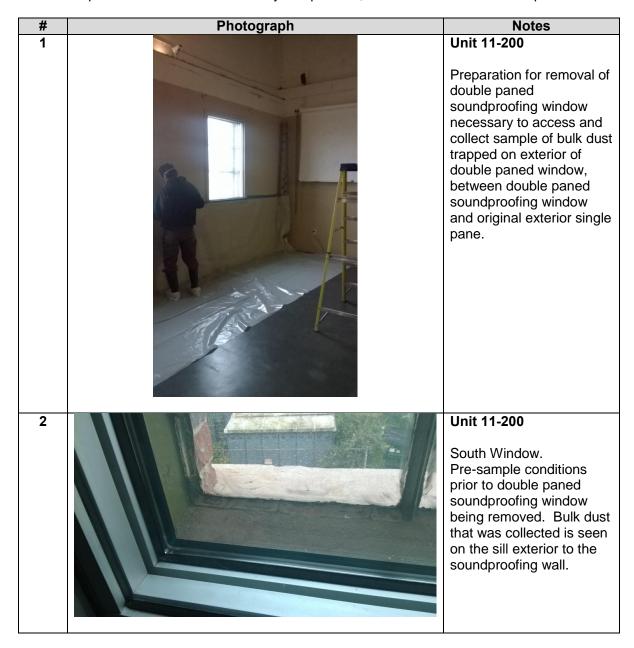
ND = None Detected (Less than RL)

< = Less than #, # = RL = Reporting Limit of Instrument



Photographs

The following photographs provide visual information and examples about the testing conditions when samples were collected. Not every sample date, location and condition is depicted:





3



Unit 11-200 PRE-Cleaning

North Window.
Pre-sample conditions prior to double paned soundproofing window being removed. Removal of interior double pane window was necessary in order to access exterior sill area between double paned window and original single paned window.

4



Unit 11-200 PRE-Cleaning SURFACE "WIPE" – PCBs

Inside pane surface of "sound proofing glass" Sample A-1

Testing Result Summary: No PCBs detected.

5



Unit 11-200 POST-Cleaning SURFACE "WIPE" -PCBs

Inside pane surface of "sound proofing glass" Sample A-2

Testing Result Summary: No PCBs detected



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Unit 11-200 PRE-Cleaning SURFACE "WIPE" -PCBs

Inside pane surface of "structural glass" or original exterior single pane window

Sample D-1

Testing Result Summary: No PCBs detected.

Photo shows 100 cm² template on glass surface.

7

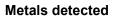


Unit 11-200 PRE-Cleaning Settled Dust

South Window - window sill exterior to double paned sound proofing window, between double paned and single paned window

Sample 102714-BULK-1

Testing Result Summary: PCBs detected 3,100 PPM



Chromium, Copper and Zinc. No Nickel detected.

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Unit 11-200 PRE-Cleaning Settled Dust

North Window - window sill exterior to double paned sound proofing window, between double paned and single paned window

Sample 102714-BULK-2

Testing Result Summary: PCBs detected 11,800 PPM



Metals detected
Chromium, Copper and
Zinc. No Nickel detected.

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Unit 11-200
POST-Cleaning
View showing clean
interstitial south window
sill after double paned
soundproofing glass reinstalled.



10



Unit 11-200 POST-Cleaning

View showing clean interstitial north window sill after double paned soundproofing glass reinstalled.

11



Unit 10-200 PRE-Cleaning SURFACE "WIPE" – PCBs

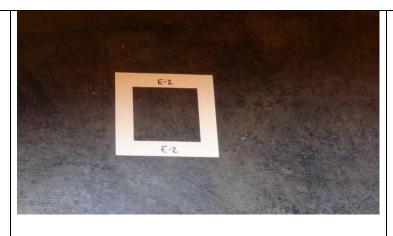
Floor in front of windows **Sample E-1**

Testing Result Summary: PCBs detected 27.7 µg/100 cm2

It was reported that previous testing for PCBs by the tenant was performed in the area to the right, so care was taken not to collect samples in that area to control for any cleaning effect the prior sampling may have provided.



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Unit 10-200
POST-Cleaning
SURFACE "WIPE" –
PCBs

Floor in front of windows **Sample E-2**

Testing Result Summary: PCBs detected 2.1 µg/100 cm2

Sample collected in area not previously tested.

Closing

This document is the sole property of NVL Laboratories and Rainier Commons, the building owner.

NVL appreciates the opportunity to provide the testing service to Rainier Commons and trust this report documenting the sample collection and results meets your needs as requested. Please contact NVL if information is needed at any time regarding the information provided in this report.

ATTACHMENTS:

- NLV Laboratories, INC. Laboratory Reports:
 - Polychlorinated Biphenyls (PCBs), SURFACE "WIPE" Batch No: 1419115,1500682,1501497
 - o Polychlorinated Biphenyls (PCBs), BULK SETTLED DUST Batch No: 1419129
 - o Metals, BULK SETTLED DUST Batch No: 1419125

Analysis Report Polychlorinated Biphenyls (PCBs)



Client: NVL Laboratories, Inc.

Address: 4708 Aurora Ave N

Seattle, WA 98103

Attention: Mr. Marcus Gladden

Project Location: 3100 Airport Way South

Seattle, WA 98134

NVL Batch No. 1419115.00

Method No. EPA 8082 Client Project # 2012-494 Dave Received: 10/27/2014

Matrix: Wipe

Samples Received: 10 Samples Analyzed: 10

Lab Sample ID:	14134652	14134653	14134654	14134655
Client Sample ID:	A-1	A-2	B-1	B-2
Sample Description:	Inside pane surface "sound proofing glass" - S. window W. elevation - Bldg, 11-200- Before cleaning	After cleaning - South window	Inside "structural glass" - Before cleaning	After cleaning
Sample Area (cm2)	100.0	100.0	100.0	100.0
PCB Type	ug/100 cm2	ug/100 cm2	ug/100 cm2	ug/100 cm2
Aroclor 1016	ND	ND	ND	ND
Aroclor 1221	ND	ND	ND	ND
Aroclor 1232	ND	ND	ND	ND
Aroclor 1242	ND	ND	ND	ND
Aroclor 1248	ND	ND	ND	ND
Aroclor 1254	ND	ND	ND	ND
Aroclor 1260	ND	ND	ND	ND
4				
Total: PCB Concentration	ND	ND	ND	ND
Reporting Limit (RL):	2.0	2.0	2.0	2.0

Remarks: ug/100 cm2 = Micrograms per 100 square centimeter

Sample area based on cm2 per wipe

ND = None Detected (<RL)

<RL = Below the reporting limit of instrument

Sampled by: Client

Reviewed by: Nick Ly

Analyzed by: Evelyn Ahulu

Analysis Date: 10/28/2014 Reviewed Date: 10/29/2014

For ! Nick Ly, Technical Director

Preparation and analysis of these samples were conducted in accordance with published test methods. Unless stated otherwise, the condition of all samples was acceptable at time of receipt. Reported sample results are based on dry weight and method QC results are acceptable unless stated otherwise. If samples were not collected by NVL personnel, then the accuracy of the results is limited by the methodology and acuity of the sample collector. This report shall not be reproduced except in full, without written approval of NVL Laboratories, Inc.. Responsibility for interpretation of the reported data rests with the client.

Analysis Report Polychlorinated Biphenyls (PCBs)



Client: NVL Laboratories, Inc. Address: 4708 Aurora Ave N

Seattle, WA 98103

Attention: Mr. Marcus Gladden

NVL Batch No. 1419115.00

Method No. EPA 8082 Client Project # 2012-494

Dave Received: 10/27/2014

Matrix: Wipe

Samples Received: 10 Samples Analyzed: 10

Project Location: 3100 Airport Way South

Seattle, WA 98134

Lab Sample ID:	14134656	14134657	14134658	14134659
Client Sample ID:	C-1	C-2	D-1	D-2
Sample Description:	Inside pane - North Window - Before cleaning	Inside pane - North Window - After cleaning	Inside "structural glass" North window - Before cleaning	After cleaning
Sample Area (cm2)	100.0	100.0	100.0	100.0
PCB Type	ug/100 cm2	ug/100 cm2	ug/100 cm2	ug/100 cm2
Aroclor 1016	ND	ND	ND	ND
Aroclor 1221	ND	ND	ND	ND
Aroclor 1232	ND	ND	ND	ND
Aroclor 1242	ND	ND	ND	ND
Aroclor 1248	ND	ND	ND	ND
Aroclor 1254	ND	ND	ND	ND
Aroclor 1260	ND	ND	ND	ND
Total: PCB Concentration	ND	ND	ND	ND
Reporting Limit (RL) :	2.0	2.0	2.0	2.0

Remarks: ug/100 cm2 = Micrograms per 100 square centimeter

Sample area based on cm2 per wipe

ND = None Detected (<RL)

<RL = Below the reporting limit of instrument

Sampled by: Client

Reviewed by: Nick Ly

Analyzed by: Evelyn Ahulu

Analysis Date: 10/28/2014 Reviewed Date: 10/29/2014

Nick Ly, Technical Director

Preparation and analysis of these samples were conducted in accordance with published test methods. Unless stated otherwise, the condition of all samples was acceptable at time of receipt. Reported sample results are based on dry weight and method QC results are acceptable unless stated otherwise. If samples were not collected by NVL personnel, then the accuracy of the results is limited by the methodology and acuity of the sample collector. This report shall not be reproduced except in full, without written approval of NVL Laboratories, Inc.. Responsibility for interpretation of the reported data rests with the client.

Analysis Report Polychlorinated Biphenyls (PCBs)



Client: NVL Laboratories, Inc. Address: 4708 Aurora Ave N

Seattle, WA 98103

Attention: Mr. Marcus Gladden

Project Location: 3100 Airport Way South

Seattle, WA 98134

NVL Batch No. 1419115.00

Method No. EPA 8082 Client Project # 2012-494 Dave Received: 10/27/2014

Matrix: Wipe

Samples Received: 10 Samples Analyzed: 10

	-		7	r
Lab Sample ID:	14134660	14134661		
Client Sample ID:	E-1	E-2		
Sample Description:	Floor in front of windows - Before cleaning	After cleaning		
Sample Area (cm2)	100.0	100.0		
PCB Type	ug/100 cm2	ug/100 cm2		
Aroclor 1016	ND	ND		
Aroclor 1221	ND	ND		
Aroclor 1232	ND	ND		
Aroclor 1242	ND	ND		
Aroclor 1248	ND	ND		
Aroclor 1254	41.7	4.6		
Aroclor 1260	69.2	3.8		
Total: PCB Concentration	110.9	8.4		
Reporting Limit (RL) :	20.0	2.0		

Remarks: ug/100 cm2 = Micrograms per 100 square centimeter

Sample area based on cm2 per wipe

ND = None Detected (<RL)

<RL = Below the reporting limit of instrument

Sampled by: Client

Analyzed by: Evelyn Ahulu Reviewed by: Nick Ly Analysis Date: 10/28/2014 Reviewed Date: 10/29/2014

Nick Ly, Technical Director

Preparation and analysis of these samples were conducted in accordance with published test methods. Unless stated otherwise, the condition of all samples was acceptable at time of receipt. Reported sample results are based on dry weight and method QC results are acceptable unless stated otherwise. If samples were not collected by NVL personnel, then the accuracy of the results is limited by the methodology and acuity of the sample collector. This report shall not be reproduced except in full, without written approval of NVL Laboratories, Inc.. Responsibility for interpretation of the reported data rests with the client.

4708 Aurora Ave N, Seattle, WA 98103 Tel: 206.547.0100 Emerg. Cell: 206.914.4646 1.888.NVL.LABS (685.5227) www.nvllabs.com

CHAIN of CUSTODY SAMPLE LOG



Client NVL Laboratories Inc Street 4708 Aurora Ave N Seattle, WA 98103 Total Samples O Total Sample O Total Samples O Total Sample O Total Samples O Total Samples	1.000.74	L.L. NDO (O	00.0221)	WWW.11V11ab3.com	. 1						
Total Samples C		Client N	VL Labo	ratories Inc							
Turn Around Time 1-Hr 8-Hrs 1/2 P 5 6-10		Street 47	708 Auro	ra Ave N			Client Jol	Number 2012-49	94		
oject Location 3100 Airport Way South Seattle, WA 98134 Phone: (206) 447-0263 Fax: (206) 447-0299 Asbestos Air PCM (NIOSH 7400) TEM (NIOSH 7402) TEM (AHERA) TEM (EPA Level II) Other Asbestos Bulk PLM (EPA Goovrestry) Asbestos Bulk PLM (EPA Goovrestry) Mold Air Mold Bulk Rotometer Calibration METALS Total Metals FAA (ppm) Air Filter FORA (ppm) Drinking water Paint Chips in ce GFAA (ppm) Total Metals FAA (ppm) FORA (ppm) Drinking water Paint Chips in ce GFAA (ppm) Total Metals FAA (ppm) Total Metals FAA (ppm) FORA (ppm) Drinking water Paint Chips in ce GFAA (ppm) Total Metals FAA (ppm) FORA		Se	eattle, W	'A 98103			Total	Samples 10			
Seattle, WA 98134 Seattle, WA 98134 Phone: (206) 447-0263 Fax: (206) 447-0299 Asbestos Air PCM (NIOSH 7400) TEM (NIOSH 7402) TEM (AHERA) TEM (EPA Level II) Other Asbestos Bulk PLM (EPA Goovredry) TEM BULK Mold/Fungus Mold Air Mold Bulk Rotometer Calibration METALS FAA (ppm) Air Filter Soil Arsenic (As) Chromium (C) Copper (Cu) Nickel (NI) Zinc (Zn) Nickel (NI) Zinc (Zn) Zi	roject M	lanager <u>M</u>	unaf Kh	an			Turn Aro	und Time 🔲 1-Hr			
Seattle, WA 98134 Phone: (206) 447-0263 Fax: (206) 447-0299 Asbestos Air PCM (NIOSH 7400) TEM (NIOSH 7402) TEM (AHERA) TEM (EPA Level II) Other								=		' ∐ 6-	10
Phone: (206) 447-0263	•							_		s than 24 H	rs
Asbestos Air							Emai	l address		9	
Asbestos Bulk PLM (EPA/600/R-93/116) PLM (EPA Point Count) PLM (EPA Gravimetry) TEM BULK Mold/Fungus Mold Air Mold Bulk Rotometer Calibration Mold Air Mold Bulk Rotometer Calibration Total Metals FAA (ppm) Plm (EPA (ppm) Pl		Phone: (2	06) 447	-0263 Fax:	(206) 447-	-0299					
Mold/Fungus Mold Air Mold Bulk Rotometer Calibration RCRA Metals All 8 Other Metals Total Metals FAA (pm) Air Filter Drinking water Dust/wipe (Area) Paint Chips in % Barhum (Ba) Lead (Pb) Nickel (Ni) Zinc (Zn)	Asbe	estos Air	□ РСМ	(NIOSH 7400)	TEM (N	IOSH 7402)	TEM (A	HERA) 🗌 TEM (EPA Level II)	Other	
METALS Total Metals FAA (ppm) FAA (ppm) Dirikking water Paint Chips in % Barium (Ba) Lead (Pb) Nickel (Ni) Zine (Zn)	Asbe	estos Bulk	☐ PLM	(EPA/600/R-93/1	16) 🗌 PL	_M (EPA Poi	nt Count) [PLM (EPA Gravi	metry) 🔲 TEN	N BULK	
Total Metals	☐ Mold	d/Fungus	☐ Mold	Air Mold Bull	k 🔲 Ro	tometer Ca	libration				
Condition of Package: Good Damaged (no spillage) Severe damage (spillage) Seq. # Lab ID Client Sample Number Comments A/R A-I TUSING PANE SURFACE SOUND PROVENCE B LASS SOUTH WINDOW WEST ELEVATION B LOG II-200 - BEFORE CLEANING A-Z AFTER CLEANING B LASS STRUCTURAL GLASS BEFORE CLEANING C-I INSIDE PANE - SHORTH WINDOW - SET B C-Z W W WINDOW - SET W WINDOW - SET INSIDE PANE - SHORTH WINDOW - SET W WINDOW - SET INSIDE PANE - SHORTH WINDOW - SET W WINDOW - SET INSIDE PANE - SHORTH WINDOW - SET W WINDOW - SET INSIDE STRUCTURAL GLASS WORTH WINDOW - SET INSIDE STRUCTURAL GLASS	☐ Total ☐ TCLF ☐ Cr 6	l Metals	☐ FAA ☐ ICP (☐ GFA	(ppm) Air Fili (ppm) Drinkii A (ppb) Dust/v	ng water wipe (Area)	☐ Paint 0	Chips in %	Arsenic (As) [Barium (Ba) [Cadmium (Cd) [Chromium (C Lead (Pb) Mercury (Hg)	All 3 Copper Nickel	r (Cu) (Ni)
Seg. # Lab ID Client Sample Number Comments A-I TUSING PANE SURFACE SOUND PROJECTION BLOG II-200 - BEFORE CLEANING A-Z AFTER CLEANING B-J TUSING STRUCTURAL GLASS - BEFORE CLEANING B-J TUSING STRUCTURAL GLASS - BEFORE CLEANING C-J INSIDE PANE - SUNORTH WINDOW - CEANING B-J INSIDE STRUCTURAL GLASS WORTH WINDOW - CEANING B-J INSIDE STRUCTURAL GLASS WORTH WINDOW - CEANING III	of Ar	nalysis	Silica	Resnir	able Dust		7,45		Les Santan	1920	
A-I INSIDE PANE SURFACE SOUND PROCESSA GLASS" SOUTH WNOOLD WEST ELENATION BLOG 11-200 - BEFORE CLEANING A-Z AFTER CLEANING B-I INSIDE STRUCTURAL GLASS BEFORE CLEANING TO CI INSIDE PANE - SOUND THE WINDOW - BEFORE B-I INSIDE STRUCTURAL GLASS WORTH WINDOW - BEFORE B-I INSIDE STRUCTURAL GLASS BEFORE CLEANING B-I INSIDE STRUCTURAL GLASS BEFOR	Conditio	on of Packa	age: 🗌	Good 🗌 Damag	jed (no spill	lage) 🗌 S	evere damaç	ge (spillage)			
3 3 3 3 3 3 3 3 3 3 3 3 3	Seq.#	Lab ID		Client Sample	Number C	Comments					A/R
3 3 3 3LOG, 1/-200 - BEFORE CLEANING 4 A-Z AFTER CLEANING 5 B-I TUSIDE "STRUCTURAL GLASS" BEFORE CLEANING 7 C-I INSIDE PANE - SHORTH WINDOW - CLEANING 8 C-Z W " " "-AFTER CLEANING 10 D-Z AFTER CLEANING 11 FOR TOWN OF STRUCTURAL GLASS" WORTH WINDOW - CLEANING 11 12 FOR TOWN OF WINDOWS - BFORE 12 FOR TOWN OF WINDOWS - BFORE 13 14 NOTE: ALL WIPE AREAS = 100 cm² 15 Print Below Sign Below Of the Company Date Time 16-27-4 12 Note 17 Received by Analyzed by Every Ahmy William NVL 10-28-14-15:30 Results Called by Results Faxed by Special Instructions: Unless requested in writing, all samples will be disposed of two (2) weeks after analysis.	1				A-1]	INSIDE	PANE	SURFACE "S	OUND PRO	3F1N6	
3 3 3 3 3 3 3 4 3 4 4 4 4 4	2										TON
A TRIES CLEANING THIS DE STRUCTURAL GUASS - BEFORE CEANING R-2 AFTER CLEANING TO C-1 INSIDE PANE - SONORTH WINDOW - CEANING B C-2 II	3										
B-I TNS/DE STRUCTVRAL GLASS - BEFORE CLAM B-2 AFTER CLEAN/NG C-1 /NS/DE PANE - SHOP TH W/NORW - CLEAN B-2 AFTER CLEAN/NG C-2 II "" "AFTER CLEAN/NG D-1 /NS/DE "STRUCTVRAL GLASS "NORTH W/NORW - CLEAN/NG 10 D-2 AFTER CLEAN/NG 11 E-1 FLOOR - /N FRONT OF W/NORWS - BFORE 12 E-2 AFTER CLEAN/NG 13 ALL WIRE AREAS = 100 cm² 15 Print Below Sign Below! Sampled by PANE LEONAR Sign Below! Received by Analyzed by EVEYN Ahmun NVL 10/28 Ity 15:30 Results Called by Results Faxed by Results Faxed by Special Instructions: Unless requested in writing, all samples will be disposed of two (2) weeks after analysis.	4								~0VI-	7.0 1.1	Ina
B-Z AFTER CLEANING TO INSIDE PANE - SONORTH WINDOW - SETO B C-Z II "" "" "AFTER CLEANING 9 D-I INSIDE "STRUCTURAL GLASS" WORTH WINDOW - SETO 10 D-Z AFTER CLEANING 11 E-I FLOOR - IN FRONT OF WINDOWS BFOR 12 E-Z AFTER CLEANING 13 NOTE ' ALL WIPE AREAS = 100 cm² 15 Print Below Sign Below! Sampled by TANC GONARY Received by Analyzed by Every flow with a sample will be disposed of two (2) weeks after analysis.	5								145-PK	FOOF (_
7 C-1 INSIDE PANE - SINOPTH WINDOW - SEFER BOOK THE WI	6										
8 C-2 "" "" "AFTER CLEANING 10 D-2 AFTER CLEANING 11 E-1 FLOUR - IN FRONT OF WINDOWS - FFORM 12 13 14 NOTE: A ALL WIRE AREAS = 100 cm ² 15 Print Below Sign Below Received by Received by Analyzed by Results Called by Results Faxed by Results Faxed by Special Instructions: Unless requested in writing, all samples will be disposed of two (2) weeks after analysis.	7								TH WIND	aul - E	CFC
9 D-I INSIDE "STRUCTURAL GLASS" WORTH WWOOD TO DE TO								//			EAN
10 11 12 13 14 Note: ALL WIPE AREAS = 100 cm² 15 Print Below Sign Below: Company Date Time Sampled by Received by Analyzed by Everyn Annua Chapan Analyzed by Everyn Annua Chapan Note: All Wipe Areas = 100 cm² Results Called by Results Faxed by Special Instructions: Unless requested in writing, all samples will be disposed of two (2) weeks after analysis.							1157011	TUDA CIA			
11 FLOUR - IN FRONT OF WINDOWS - RETAINED 13 14 NOTE: ALL WIPE AREAS = 100 cm ² 15 Print Below Sign Below: Company Date Time Sampled by Relinquished by Received by Chapter Analyzed by Every Annual Chapter Annual Company Date Time 14:30 Received by Chapter Annual Chapter Annual Company Date Time 14:30 Results Called by Results Called by Results Faxed by Special Instructions: Unless requested in writing, all samples will be disposed of two (2) weeks after analysis.									SS NORTH	vojnov.	
13 14 NOTE: ALL WIPE AREAS = 100 cm² 15 Print Below Sign Below: Company Date Time Sampled by Received by Received by Analyzed by Everyn Annu NVL 10/28/14/15/30 Received by Results Called by Results Faxed by Results Faxed by Received Instructions: Unless requested in writing, all samples will be disposed of two (2) weeks after analysis.									41.0100	10.10 I	>
13 14 NOTE: ALL WIPE AREAS = 100 cm² 15 Print Below Sign Below Company Date Time Sampled by PAVE GOVAN AND AND TOTAL INCOMPANY AND TOTAL INCOMPAN									WINDU	102-6	STOR
Print Below Sign Below Company Date Time Sampled by Print Below Sign Below Company Date Time Relinquished by Marcus Glapoon 14:30 Received by Analyzed by Everyn Home NVL 10/28 14:15:30 Results Called by Results Faxed by Special Instructions: Unless requested in writing, all samples will be disposed of two (2) weeks after analysis.					F 2 +	1-1-15	CCE	400700			-
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Relinquished by Manus Glacorn Received by Chroch Manus Glacorn Analyzed by Evelyn Hanu Manus Glacorn Results Called by Results Faxed by Special Instructions: Unless requested in writing, all samples will be disposed of two (2) weeks after analysis.				The state of the s	Sign Below	\mathcal{O}	0			- Constant	
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Results Called by Results Faxed by Special Instructions: Unless requested in writing, all samples will be disposed of two (2) weeks after analysis.			Y II A					-th	7	, [4]	30
Results Called by Results Faxed by Special Instructions: Unless requested in writing, all samples will be disposed of two (2) weeks after analysis.					Atte	De.	1		9	27/ly 2	30
Results Faxed by Special Instructions: Unless requested in writing, all samples will be disposed of two (2) weeks after analysis.				lyn Ahnlu	1	Made	m	NVL	10/	18/14/	5:30
Special Instructions: Unless requested in writing, all samples will be disposed of two (2) weeks after analysis.	Result	s Called by	у	•						,	
	Result	ts Faxed by	y								
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resource report to	-			1000 Toquested III	winning, all	Janipies Wi	i no dishosei	a or two (2) weeks a	anor analysis.		
	งออนแอ	, report to									

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Analysis Report

Total Metals

Client: NVL Field Services Division

Address: 4708 Aurora Ave. N.

Seattle, WA 98103

Attention: Mr. Marcus Gladden

Project Location: 3100 Airport Way South Seattle, WA 98134

Batch #: 1419125.00

Matrix: Paint

Method: EPA 3051/6010C

Client Project #: 2012-494

Date Received: 10/27/2014

Samples Received: 2 Samples Analyzed: 2

Lab ID	Client Sample #	Elements	Sample wt (g)	RL mg / kg	Results in mg / kg	Results in ppm
14134693	102714-BULK-1	Chromium (Cr)	0.0604	66.0	130.0	130.0
		Copper (Cu)	0.0604	66.0	89.0	89.0
		Nickel (Ni)	0.0604	66.0	< 66.0	< 66.0
		Zinc (Zn)	0.0604	66.0	64000.0	64000.0
14134694	102714-BULK-2	Chromium (Cr)	0.2092	19.0	130.0	130.0
		Copper (Cu)	0.2092	19.0	0.08	80.0
		Nickel (Ni)	0.2092	19.0	< 19.0	< 19.0
		Zinc (Zn)	0.2092	19.0	32000.0	32000.0

Sampled by: Client

Analyzed by: Shalini Patel

Reviewed by: Nick Ly

ppm = Parts per million

Bench Run No: 34-1028-05

Note: Method QC results are acceptable unless stated otherwise.

Unless otherwise indicated, the condition of all samples was acceptable at time of receipt.

Date Analyzed: 10/28/2014

Date Issued: 10/28/2014

mg/ kg = Milligrams per kilogram

RL = Reporting Limit
'<' = Below the reporting Limit

Technical Director

Page 1 of 1

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CHAIN of CUSTODY SAMPLE LOG



	L.LABS (685.522)	7) www.tivilabs.com		
	Client NVL Lab	oratories Inc	NVL Batch Number	
	Street 4708 Au	rora Ave N	Client Job Number 2012-494	
	Seattle,	WA 98103	Total Samples 2	_
	anager Munaf K		Turn Around Time 11-Hr 8-Hrs 12 12-14-15 13	
Project Lo	ocation 3100 Air	port Way South		-10
•		WA 98134	Please call for TAT less than 24 H	lrs
			Email address	
	Phone: (206) 44			
Asbe	estos Air PC	M (NIOSH 7400) 🗌 TEM (NIOSH		
Asbe	estos Bulk 🔲 PLI	M (EPA/600/R-93/116)	EPA Point Count) PLM (EPA Gravimetry) TEM BULK	
<u> </u>	/Fungus	ld Air Mold Bulk Rotom	eter Calibration	1 1
METALS Total TCLF Cr 6	Metals ☐ FA.	A (ppm) Air Filter Drinking water	RCRA Metals Soil Arsenic (As) Paint Chips in % Barium (Ba) Paint Chips in cr □ Cadmium (Cd) All 8 Chromium (C Lead (Pb) Mercury (Hg)	r (Cu (Ni)
		701 (ppb)	∑ ∠inc (∠	(n)
Othe			Other (Specify) PCB'S - BULK EPA 808Z	
-	nalysis Silic on of Package:	The state of the s) Severe damage (spillage)	
Seq.#	Lab ID	Client Sample Number Com		A/F
1		102714-Buk-1 S	. WINDOW	+
2		+ -2 N	. WINDOW	+
3				+
4				+
5				+
6	12			-
7				+
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				+
13				+-
14				
		<u> </u>		
14	Print	Below Sign Below	Company Date Time	е
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14 15	10. 10.000	NE GONARD IN LE		نن
14 15 S Reline	Sampled by DA	NE GONARD IN DE	10/27/14/12: 14:	نن
14 15 S Relinc	Sampled by DA	NE GONARD IN DE	NUL 10 27 14 12:	00
14 15 S Reline R	campled by Oxional Control of the Co	NE GONARD IN DE	10/27/14/12: 14:	<i>5</i> 0

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Analysis Report Polychlorinated Biphenyls (PCBs)



Client: NVL Field Services Division

Address: 4708 Aurora Ave. N.

Attention: Mr. Marcus Gladden

Seattle, WA 98103

Project Location: 3100 Airport Way South Seattle, WA 98134

NVL Batch #: 1419129.00

Method No.: EPA 8082

Client Project #: 2012-494

Date Received: 10/27/2014

Matrix: Bulk

Samples Received: 2

Samples Analyzed: 2

Lab Sample ID:	14134695	14134696
Client Sample ID:	102714-BULK-1	102714-BULK-2
Sample Description:	S. Window	N. Window
Sample Weight (g)	0.0923	1.3903
PCB Type	mg/Kg(ppm)	mg/Kg(ppm)
Aroclor 1016	ND	ND
Aroclor 1221	ND	ND
Aroclor 1232	ND	ND
Aroclor 1242	ND	ND
Aroclor 1248	ND	ND
Aroclor 1254	1100.00	4200.00
Aroclor 1260	2000.00	7600.00
Total: PCB Concentration	3100.0	11800.0
Reporting Limit (RL)	220.0	1400.0

Remarks: mg/Kg = Milligrams per kilogram

ND = None Detected (less than RL)

ppm = Parts per million by weight

<RL = Below the reporting limit of instrument

Sampled by: Client

Analyzed by: Evelyn Ahulu Date:10/28/2014

Reviewed by: Nick Ly Date: 10/29/2014

Many

Nick Ly, Technical Director

Preparation and analysis of these samples were conducted in accordance with published test methods. Unless stated otherwise, the condition of all samples was acceptable at time of receipt. Reported sample results are based on dry weight and method QC results are acceptable unless stated otherwise. If samples were not collected by NVL personnel, then the accuracy of the results is limited by the methodology and acuity of the sample collector. This report shall not be reproduced except in full, without written approval of NVL Laboratories, Inc.. Responsibility for interpretation of the reported data rests with the client.

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CHAIN of CUSTODY SAMPLE LOG



1419129

	L.LABS (003.324	27) www.iiviiabs.cc	וווע		*		
	Client NVL La	boratories Inc			tch Number		
	Street 4708 A	urora Ave N		Client .	Job Number 2012	-494	
	Seattle,	WA 98103		To	tal Samples		
Project M	anager Munaf I	Khan		Turn A	round Time 🔲 1-h		Day [] 5
		rport Way South			☐ 2-H ☐ 4-H	-lrs ☐ 12-Hrs ☐ 3 Hrs ☐ 24-Hrs ☐ 4	_
	Seattle,	WA 98134				Please call for TAT les	
				En	nail address		
	Phone: (206) 4	47-0263 Fax:	(206) 447-029	9	_		
☐ Asbe	stos Air Po	CM (NIOSH 7400)	TEM (NIOS	H 7402) 🗌 TEM	(AHERA) 🗌 TEN	M (EPA Level II)	Other
☐ Asbe	stos Bulk 🗌 PL	M (EPA/600/R-93/	/116) 🗌 PLM (EPA Point Count)	PLM (EPA Gr	avimetry) 🗌 TEI	M BULK
_ ☐ Mold	/Fungus 🔲 Mo	old Air 🔲 Mold Bu	ulk Rotom	eter Calibration			
METALS Total TCLF Cr 6	Metals ☐ FA	AA (ppm) Air F P (ppm) Drinl	king water [/wipe (Area) [Cadmium (Cd)	- , -,	Other Metals All 3 Copper (C Nickel (Ni) Zinc (Zn)
4	r Types Fib lalysis Sil n of Package: [ica Resn	ance Dust X irable Dust aged (no spillage		PCB's - Buck nage (spillage)	EPA	808Z
					nage (spiliage)		
Seq. #	Lab ID		e Number Com				A/
1		102714 - Bu					
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		Va Va a Di	0 / 7	1100 -	117	10/7:	1111111
		1001 ILOU	A A C I	1012	_ W.	1010	1191 6
	nalyzed by						
Results	Called by						
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CHAIN of CUSTODY SAMPLE LOG



	NN/I laba	rotorios Inc	NVL Batch Number
	Client NVL Labor		Client Job Number 2012-494
	Street 4708 Auro Seattle, W.		Total Samples 2
Design of M	anager Munaf Kha		Turn Around Time 1-Hr 8-Hrs X2 12 15
Project Ma	cation 3100 Airpo	ort Way South	2-Hrs 12-Hrs 3 6-10
Project Lo	Seattle, W	'A 98134	—————————————————————————————————————
	550		Email address
j	Phone: (206) 447-	-0263 Fax : (206) 44	
			IOSH 7402) TEM (AHERA) TEM (EPA Level II) Other
Asbe	stos Bulk PLM	(EPA/600/R-93/116)	M (EPA Point Count) PLM (EPA Gravimetry) TEM BULK
Mold	/Fungus Mold		tometer Calibration
METALS Total TCLP Cr 6	Metals	(ppm) Air Filter (ppm) Drinking water	IX Zinc (∠n)
	r Types Fiberg nalysis Silica n of Package:	Respirable Dust	Severe damage (spillage) Severe damage (spillage)
		1	
Seq. #	Lab ID	Client Sample Number	
1		102714 - BULK - 1	S. WINDOW
2		+ -2	N. WINDOW
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	Print B	Below Sign Belo	
	Sampled by DAV	E GEONARD JA	NUL 10/27/14/12:00
Relin	quished by	*	14:3
R	Received by Wi(Jankoki &	//m hu 1921 19 19
	nalyzed by		
Α			
	s Called by		

January 20, 2015

Mr. Munaf Khan NVL Field Services Division 4708 Aurora Ave. N. Seattle, WA 98103

Re: NVL Batch 1500682.00

Project Name/Number: 2012-494

Project Location: 3100 Airport Way South Seattle, WA 98134

Dear Mr. Khan,

Enclosed please find test results for sample submitted to our laboratory for analysis. Preparation and analysis of these samples were conducted in accordance with methods specified on the attached test reports.

The content of this package consists of the following:

Case Narrative & Definition of Data Qualifiers Analytical Test Results Applicable QC Summary Client Chain -of-Custody (CoC)

This report package contains a total of 13 pages of analytical test results along with customer CoC and other related documents. The report is considered highly confidential and will not be released without your approval. Samples are archived for two weeks following analysis. Samples that are not retrieved by the client will be discarded after two weeks.

Thank you for using our laboratory services. If you need further assistance, please contact us at 206-547-0100 or 1-888-NVLLABS.

Sincerely

Nick Ly, Technical Director.

L A B S

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Case Narrative:

The following summarizes samples received on date as shown on the accompanied Chain of custody by NVL Laboratories, Inc. from NVL Field Services Division for Project No.2012-494. Samples were logged in for PCB analysis per client request using both customer sample ID's and laboratory assigned ID's as listed on the Chain-of-Custody (CoC). All samples as received were processed and analyzed within specified turnaround time without any abnormalities and deviations that may affect the analytical results. All quality control requirements were acceptable unless stated otherwise. The conditions of all samples were acceptable at time of receipt and all samples submitted with this batch were analyzed unless stated otherwise on the CoC.

Test Results are reported based on microgram per 100cm² for PCB samples as shown on the analytical reports.



Definition Appendix

Terms

% Rec Percent recovery. Below Reporting Limit(RL) or Limit of Quantitation(LoQ) of the < instrument. Blank contamination. The recorded results is associated with a В contaminated blank. DF Dilution Factor J The reported concentration is an estimated value because something may be present in the sample that interfered with the analysis. J1 The reported concentration is an estimated value because the laboratory control sample (LCS) is out of control limits. J2 The reported concentration is an estimated value because the percent recovery for matrix spike is out of control limits. J3 The reported concentration is an estimated value because the relative percent difference(RPD) for duplicate analysis is out of control limits. J4 Percent recovery is outside of established control limits. LCS Laboratory Control Sample. Limits The upper and lower control limits for spike recoveries. LOQ Limit of quantitation(same as RL) mg/kg Milligrams per kilogram. ND Analyte not detected or below the reporting limit of the instrument or methodology PPM Parts per Million. QC Batch Group Quality Control Batch Group. The entity that links analytical results and supporting quality control results.



Definition Appendix

Terms

R The data are not reliable due to possible contamination or loss of

material during preparation or analysis. Re-sampling and reanalysis

are necessary for verification.

RL Reporting Limit. The minimum concentration that can be quantified

under routine operating conditions.

RPD Relative Percent Difference. The relative difference between

duplicate results(matrix spike, blank spike, or samples duplicate)

expressed as a percentage.

RPD Limit The maximum RPD allowed for a set of duplicate

measurements(see RPD).

SMI Surrogate has matrix interference.

Spike Conc. The measured concentration, in sample basis units, of a spiked

sample.

SURR-ND Surrogate was not detected due to matrix interference or dilution.

ug/m3 Micrograms per cubic meter.

ug/mL Micrograms per milliliter

ug Microgram

ug/100cm2 Micrograms per 100 square centimeters

ORGANICS LABORATORY SERVICES



Α

Α

NVL Batch Number 1500682.00 Company NVL Field Services Division Address 4708 Aurora Ave. N. TAT 5 Days AH No Seattle, WA 98103 Rush TAT 1:35 PM 1/20/2015 Time **Due Date** Project Manager Mr. Marcus Gladden Phone (206) 547-0100 Email marcus.g@nvllabs.com Fax (206) 634-1936 cell (b) (6) Project Location: 3100 Airport Way South Seattle, WA 98134 Project Name/Number: 2012-494 Subcategory Quantitative analysis Item Code ORG-03 8082 PCB Aroclors <Wipe> Total Number of Samples 7 **Rush Samples** A/R Description Lab ID Sample ID Α 15003575 11215-PCB-A Α 11215-PCB-B 15003576 Α 15003577 11215-PCB-C 11215-PCB-D Α 15003578 Α

	Print Name	Signature	Company	Date	Time
Sampled by	Client				
Relinquished by	Client				
Office Use Only	Print Name	Signature	Company	Date	Time
Received by	Midori Koike		NVL	1/13/15	1335
Analyzed by	Evelvn Ahulu	Callen	NVL	1/15/15	15:00
Results Called by					
Faxed Emailed					
Special Instructions:					

Entered By: Midori Koike

Date: 1/13/2015

Time: 3:31 PM

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1 of 1

5

6

15003579

15003580

15003581

11215-PCB-E

11215-PCB-F

11215-PCB-G



Polychlorinated Biphenyls by Gas Chromatography

Client SDG Number Date Reported Project Number Location	NVL Field Services Division 1500682.00 01/20/2015 2012-494 3100 Airport Way South Seattle 98134	Samples Received* Analyzed By Samples Analyzed* Analysis Method e, WA Preparation Method	Evelyn Ahulu 7 8082A	
Sample Numbe	er 11215-PCB-A	Received	01/13/2015	
Lab Sample ID	15003575	Matrix	Dust Wipe	
Initial Sample Siz	ze 100 cm2	Units of Result	ug/100cm2	
Analyte		RL	Final Result Analysis	Date
Aroclor-1016		0.050	< 0.050 01/15/20	15
Aroclor-1221		0.050	< 0.050 01/15/20	
Aroclor-1232		0.050	< 0.050 01/15/20	
Aroclor-1242		0.050	< 0.050 01/15/20	
Aroclor-1248		0.050	< 0.050 01/15/20	
Aroclor-1254		0.050	< 0.050 01/15/20	
Aroclor-1260		0.050	< 0.050 01/15/20	15
PCBs, Total Comments: BLDG 11-2	200-South Window Sound Proofing Pane	0.050	<0.05 01/15/20	15
Sample Numbe	er 11215-PCB-B	Received	01/13/2015	
Lab Sample ID	15003576	Matrix	Dust Wipe	
Initial Sample Siz	re 100 cm2	Units of Result	ug/100cm2	
Analyte		RL	Final Result Analysis	Date
Aroclor-1016		0.050	< 0.050 01/15/20	15
Aroclor-1221		0.050	< 0.050 01/15/20	15
Aroclor-1232		0.050	< 0.050 01/15/20	15
Aroclor-1242		0.050	< 0.050 01/15/20	15
Aroclor-1248		0.050	< 0.050 01/15/20	
Aroclor-1254		0.050	< 0.050 01/15/20	
Aroclor-1260		0.050	< 0.050 01/15/20	15
PCBs, Total		0.050	<0.05 01/15/20	15

Phone: 206.547.0100 | Fax: 206.634.1936 | Toll Free: 1.888.NVL.LABS (685.5227) 4708 Aurora Avenue North | Seattle, WA 98103

Comments: BLDG 11-200-South-Structural Park



Polychlorinated Biphenyls by Gas Chromatography

Sample Number	11215-PCB-C	Received	01/13/2015
Lab Sample ID	15003577	Matrix	Dust Wipe
Initial Sample Size	100 cm2	Units of Result	ug/100cm2
Analyte		RL	Final Result Analysis Date
Aroclor-1016		0.050	< 0.050 01/15/2015
Aroclor-1221		0.050	< 0.050 01/15/2015
Aroclor-1232		0.050	< 0.050 01/15/2015
Aroclor-1242		0.050	< 0.050 01/15/2015
Aroclor-1248		0.050	< 0.050 01/15/2015
Aroclor-1254		0.050	9 01/15/2015
Aroclor-1260		0.050	5.6 01/15/2015
PCBs, Total Comments: BLDG 11-200-Sc	outh Sill	0.050	14.6 01/15/2015
Sample Number	11215-PCB-D	Received	01/13/2015
Lab Sample ID	15003578	Matrix	Dust Wipe
Initial Sample Size	100 cm2	Units of Result	ug/100cm2
Analyte		RL	Final Result Analysis Date
Aroclor-1016		0.050	< 0.050 01/15/2015
Aroclor-1221		0.050	< 0.050 01/15/2015
Aroclor-1232		0.050	< 0.050 01/15/2015
Aroclor-1242		0.050	< 0.050 01/15/2015
Aroclor-1248		0.050	< 0.050 01/15/2015
Aroclor-1254		0.050	< 0.050 01/15/2015
Aroclor-1260		0.050	< 0.050 01/15/2015
PCBs, Total		0.050	<0.05 01/15/2015

Comments: BLDG 11-200-North Window-Sound Proofing Pane



Polychlorinated Biphenyls by Gas Chromatography

Sample Number	11215-PCB-E	Received	01/13/2015
Lab Sample ID	15003579	Matrix	Dust Wipe
Initial Sample Size	100 cm2	Units of Result	ug/100cm2
Analyte		RL	Final Result Analysis Date
Aroclor-1016		0.050	< 0.050 01/15/2015
Aroclor-1221		0.050	< 0.050 01/15/2015
Aroclor-1232		0.050	< 0.050 01/15/2015
Aroclor-1242		0.050	< 0.050 01/15/2015
Aroclor-1248		0.050	< 0.050 01/15/2015
Aroclor-1254		0.050	< 0.050 01/15/2015
Aroclor-1260		0.050	< 0.050 01/15/2015
PCBs, Total Comments: BLDG 11-200-No	orth -Structural Park	0.050	<0.05 01/15/2015
Sample Number	11215-PCB-F	Received	01/13/2015
-	11215-PCB-F 15003580	Received Matrix	01/13/2015 Dust Wipe
Lab Sample ID			
Lab Sample ID Initial Sample Size	15003580	Matrix	Dust Wipe
Lab Sample ID Initial Sample Size Analyte	15003580	Matrix Units of Result	Dust Wipe ug/100cm2
Lab Sample ID Initial Sample Size Analyte Aroclor-1016	15003580	Matrix Units of Result RL	Dust Wipe ug/100cm2 Final Result Analysis Date
Sample Number Lab Sample ID Initial Sample Size Analyte Aroclor-1016 Aroclor-1221 Aroclor-1232	15003580	Matrix Units of Result RL 0.050	Dust Wipe ug/100cm2 Final Result Analysis Date < 0.050 01/15/2015
Lab Sample ID Initial Sample Size Analyte Aroclor-1016 Aroclor-1221 Aroclor-1232	15003580	Matrix Units of Result RL 0.050 0.050	Dust Wipe ug/100cm2 Final Result Analysis Date < 0.050 01/15/2015 < 0.050 01/15/2015
Lab Sample ID Initial Sample Size Analyte Aroclor-1016 Aroclor-1221 Aroclor-1232 Aroclor-1242	15003580	Matrix Units of Result RL 0.050 0.050 0.050	Dust Wipe ug/100cm2 Final Result Analysis Date < 0.050 01/15/2015 < 0.050 01/15/2015 < 0.050 01/15/2015
Lab Sample ID Initial Sample Size Analyte Aroclor-1016 Aroclor-1221 Aroclor-1232 Aroclor-1242 Aroclor-1248	15003580	Matrix Units of Result RL 0.050 0.050 0.050 0.050	Dust Wipe ug/100cm2 Final Result Analysis Date < 0.050 01/15/2015 < 0.050 01/15/2015 < 0.050 01/15/2015 < 0.050 01/15/2015
Lab Sample ID Initial Sample Size Analyte Aroclor-1016 Aroclor-1221	15003580	Matrix Units of Result RL 0.050 0.050 0.050 0.050 0.050 0.050	Dust Wipe ug/100cm2 Final Result Analysis Date < 0.050 01/15/2015 < 0.050 01/15/2015 < 0.050 01/15/2015 < 0.050 01/15/2015 < 0.050 01/15/2015 < 0.050 01/15/2015

Comments: BLDG 11-200-North Sill



Polychlorinated Biphenyls by Gas Chromatography

Sample Number	11215-PCB-G	Received	01/13/2015
Lab Sample ID	15003581	Matrix	Dust Wipe
Initial Sample Size	100 cm2	Units of Result	ug/100cm2
Analyte		RL	Final Result Analysis Date
Aroclor-1016		0.050	< 0.050 01/15/2015
Aroclor-1221		0.050	< 0.050 01/15/2015
Aroclor-1232		0.050	< 0.050 01/15/2015
Aroclor-1242		0.050	< 0.050 01/15/2015
Aroclor-1248		0.050	< 0.050 01/15/2015
Aroclor-1254		0.050	< 0.050 01/15/2015
Aroclor-1260		0.050	< 0.050 01/15/2015
PCBs, Total		0.050	<0.05 01/15/2015

Comments: Field Blank. Result is based on an assumption that 100cm2 area was used.



Phone: 206 547-0100 Fax: 206 634-1936

Quality Control Results

Project Number:	2012-494			SDG Num Project Ma			0682 naf Kha	n		
QC Batch(es):	Q242			Analysis M	lethod:	8082	4			
QC Batch Method:	3546PR (PCB)			Analysis Descr	iption:	Polyc	hlorinate	ed Bipl	nenyls by Ga	as
Preparation Date:	01/15/2015					Chror	natogra	phy		
Blank: BLANK-1500	0682									
	Blank				RL		Control			
Analyte	Result	Units	DF				Limit			Qualifiers
Aroclor-1016	ND	ug/wipe	1		0.050		0.05			
Aroclor-1221	ND	ug/wipe	1		0.050		0.05			
Aroclor-1232	ND	ug/wipe	1		0.050		0.05			
Aroclor-1242	ND	ug/wipe	1		0.050		0.05			
Aroclor-1248	ND	ug/wipe	1		0.050		0.05			
Aroclor-1254	ND	ug/wipe	1		0.050		0.05			
Aroclor-1260	ND	ug/wipe	1		0.050		0.05			
PCBs, Total	ND	ug/wipe	1		0.050		0.05			
Lab Control Sample	: MATRIX SPIKE-	1500682								
	Blank Spike			Spike			% Rec			
Analyte	Result	Units	DF	Conc.	%	6 Rec	Limits			Qualifiers
Aroclor-1254	0.192	ug/wipe	1	0.200		96	40-140			
Lab Control Sample	: LCS-1500682									
Lab Control Sample	Duplicate: LCS-D	UP-150068	32							
	Blank Spike			Spike						
Analyte	Result	Units	DF	Conc.	%	6 Rec	Limits	RPD	RPD Limit	Qualifiers
Aroclor-1016	0.184	ug/wipe	1	0.200			40-140			
	0.196			0.200			40-140	7	50	
Aroclor-1260	0.19 0.204	ug/wipe	1	0.200 0.200			40-140 40-140	7	50	

Surrogate Recovery Summary Report

Client NVL Field Services Division	<u>n</u>	SD	G Number <u>1500682</u>	
Project <u>2012-494</u>				
Customer Sample ID	Lab Sample ID	Analyte	Recovery	Limits
11215-PCB-A	15003575	Decachlorobiphenyl	89%	40-140
11215-PCB-A	15003575	Tetrachloro-m-xylene	91%	40-140
11215-PCB-B	15003576	Decachlorobiphenyl	84%	40-140
11215-PCB-B	15003576	Tetrachloro-m-xylene	90%	40-140
11215-PCB-C	15003577	Decachlorobiphenyl	87%	40-140
11215-PCB-C	15003577	Tetrachloro-m-xylene	102%	40-140
11215-PCB-D	15003578	Decachlorobiphenyl	89%	40-140
11215-PCB-D	15003578	Tetrachloro-m-xylene	93%	40-140
11215-PCB-E	15003579	Decachlorobiphenyl	92%	40-140
11215-PCB-E	15003579	Tetrachloro-m-xylene	103%	40-140
11215-PCB-F	15003580	Decachlorobiphenyl	89%	40-140
11215-PCB-F	15003580	Tetrachloro-m-xylene	103%	40-140
11215-PCB-G	15003581	Decachlorobiphenyl	85%	40-140
11215-PCB-G	15003581	Tetrachloro-m-xylene	97%	40-140
BLANK-1500682	BLANK-1500682	Decachlorobiphenyl	94%	40-140
BLANK-1500682	BLANK-1500682	Tetrachloro-m-xylene	91%	40-140
LCS-1500682	LCS-1500682	Decachlorobiphenyl	95%	40-140
LCS-1500682	LCS-1500682	Tetrachloro-m-xylene	101%	40-140
LCS-DUP-1500682	LCS-DUP-1500682	Decachlorobiphenyl	101%	40-140
LCS-DUP-1500682	LCS-DUP-1500682	Tetrachloro-m-xylene	112%	40-140
MATRIX SPIKE-1500682	MATRIX SPIKE-1500682	Decachlorobiphenyl	101%	40-140
MATRIX SPIKE-1500682	MATRIX SPIKE-1500682	Tetrachloro-m-xylene	105%	40-140

^{*} Recovery outside limits

INITIAL AND CONTINUING CALIBRATION VERIFICATION

SDG No: <u>1500682</u> Contract: <u>N/A</u>

Determination: 8082 PCB Aroclors < Wipe>

Run	Sample	Source	Analyzed	Analyte	True	Found	Unit	% Rec	Limits
R000235	CCV1- 1016-1260	PCB_2014-2-6	01/15/2015	Aroclor-1016	0.1	0.105	ug/mL	105	80-120
		PCB_2014-2-6	01/15/2015	Aroclor-1260	0.1	0.102	ug/mL	102	80-120
	CCV1- 1254	PCB_2014-2-7	01/15/2015	Aroclor-1254	0.1	0.107	ug/mL	107	80-120
	CCV2- 1016-1260	PCB_2014-2-6	01/15/2015	Aroclor-1016	0.1	0.109	ug/mL	109	80-120
		PCB_2014-2-6	01/15/2015	Aroclor-1260	0.1	0.108	ug/mL	108	80-120
	CCV2- 1254	PCB_2014-2-7	01/15/2015	Aroclor-1254	0.1	0.103	ug/mL	103	80-120

RCLLC 0004909

[%] Rec = Percent recovery

^{* =} Percent recovery not within control limits

4708 Aurora Ave N, Seattle, WA 98103

CHAIN of CUSTODY SAMPLETOG



206.547.0	100 f 206.634.1	1936] www.nvllabs.com	SAII	MF LL LOG	1500	002
	Client NVL L	aboratories Inc		NVL Batch No		
	Street 4708				ımber 2012-494	
		e, WA 98103		Total Sa	mples +	
oiect M	anager Munaf			Turn Around		3 Days 10 Days
oject I c	cation 3100 A	Airport Way South] 4 Days ⊉5 Da <u>y</u> s
0,000 =0	Seattle	e, WA 98134				AT less than 24 Hrs
				Email ad	dress	
	Phone: (206)	447-0263 Fax: (206)	447-0299			
Asbe	estos Air 🔲 F	PCM (NIOSH 7400) 🗌 TEN	1 (NIOSH 740)	2) TEM (AHER	A) TEM (EPA Level II)	Other
Asbe	estos Bulk 🗌 F	PLM (EPA/600/R-93/116)	PLM (EPA F	oint Count) 🗌 Pl	M (EPA Gravimetry)	EM BULK
Mold	l/Fungus 🔲 N	Nold Air 🔲 Mold Bulk 📗	Rotometer	Calibration		Other Metals
TCLF Cr 6	Metals F		rea) ☐ Pain t ☑ Other	t Chips in % Bat Chips in cr	A Metals	Hg) Copper (Cu) Sickel (Ni) Zinc (Zn)
onditio	n of Package:	Good Damaged (no	spillage)	Severe damage (s	piliage)	1 4 2 4
Seq.#	Lab ID	Client Sample Numb	er Comment	s	2 au 47)	ARGA AIR
1		11215-PCB	A BLDG,	11-200-5007	WINDOW BRUNGING -STRUCTURAL PA	100 cm
2			B 11	11 (1	-STRUCTURAL PA	inc 67'
3			_ 4	(1 4	- SIL2	2 /
4) 1 (1		4 WINDOW - PROCE	
5			= 11	1) (1	-STRUCTURAL	PINK
6		F			-5166	1
7		<u>e</u>	FIELD	BCANK		
8						
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			selow 🗡		ompany [Date Time
		AVE LEONARD LE			NUL	1-13-15 1335
	quished by \mathcal{V} Received by	AUE LEONARD LE		4	M	1/18/06 1335
	- 57	1 1	Call	nla	1/1/16	1115/11 10'00
	nalyzed by	velyn Almh	Crox	. 50. (NVL	1112 12,00
	s Called by	,				
	s Faxed by					
Specia	I Instructions	: Unless requested in writin	g, all samples	will be disposed of	two (2) weeks after analysi	S.
Results	report to	0.	~	/	Negoca	
		KL of	.08	July /WIPE	L NEEDED	



February 2, 2015

Mr. Munaf Khan

NVL Field Services Division 4708 Aurora Ave. N. Seattle, 98103

Re: NVL Batch 1501497.00

Project Name/Number: 2012-494

Project location: 3100 Airport Way South Seattle, WA 98134

Dear Mr. Khan,

Enclosed please find test results for samples submitted to our laboratory for analysis. Preparation and analysis of these samples were conducted in accordance with published industry standards and methods specified on the attached analytical report.

The content of this package consists of the following:

- -Case Narrative & Definition of Data Qualifiers
- -Analytical Test Results
- -Applicable QC Summary
- -Client Chain-of-Custody (CoC)
- -NVL Receiving Record

This report package contains a total of 11 pages of analytical test results along with customer COC and other related documents.

The report is considered highly confidential and will not be released without your approval. Samples are archived for two weeks following analysis. Samples that are not retrieved by the client will be discarded after two weeks.

Thank you for using our laboratory services. If you need further assistance, please contact us at 206-547-0100 or 1-888-NVLLABS.

Sincerely,

Nick Ly, Technical Director

Enclosure: Sample Results



Case Narrative:

The following summarizes samples received on date as shown on the accompanied Chain of custody by NVL Laboratories, Inc. from NVL Field Services Division for Project No. 2012-494. Samples were logged in for PCB analysis per client request using both customer sample ID's and laboratory assigned ID's as listed on the Chain-of-Custody (CoC). All samples as received were processed and analyzed within specified turnaround time without any abnormalities and deviations that may affect the analytical results. All quality control requirements were acceptable unless stated otherwise. The conditions of all samples were acceptable at time of receipt and all samples submitted with this batch were analyzed unless stated otherwise on the CoC.

Test Results are reported based on microgram per 100cm² (ug/100cm²) for PCB samples as shown on the analytical reports.



Definition Appendix

Terms

% Rec Percent recovery. Below Reporting Limit(RL) or Limit of Quantitation(LoQ) of the < instrument. Blank contamination. The recorded results is associated with a В contaminated blank. DF **Dilution Factor** J The reported concentration is an estimated value because something may be present in the sample that interfered with the analysis. J1 The reported concentration is an estimated value because the laboratory control sample (LCS) is out of control limits. J2 The reported concentration is an estimated value because the percent recovery for matrix spike is out of control limits. J3 The reported concentration is an estimated value because the relative percent difference(RPD) for duplicate analysis is out of control limits. J4 Percent recovery is outside of established control limits. LCS Laboratory Control Sample. Limits The upper and lower control limits for spike recoveries. LOQ Limit of quantitation(same as RL) mg/kg Milligrams per kilogram. ND Analyte not detected or below the reporting limit of the instrument or methodology PPM Parts per Million. QC Batch Group Quality Control Batch Group. The entity that links analytical results and supporting quality control results.



Definition Appendix

Terms

R The data are not reliable due to possible contamination or loss of

material during preparation or analysis. Re-sampling and reanalysis

are necessary for verification.

RL Reporting Limit. The minimum concentration that can be quantified

under routine operating conditions.

RPD Relative Percent Difference. The relative difference between

duplicate results(matrix spike, blank spike, or samples duplicate)

expressed as a percentage.

RPD Limit The maximum RPD allowed for a set of duplicate

measurements(see RPD).

SMI Surrogate has matrix interference.

Spike Conc. The measured concentration, in sample basis units, of a spiked

sample.

SURR-ND Surrogate was not detected due to matrix interference or dilution.

ug/m3 Micrograms per cubic meter.

ug/mL Micrograms per milliliter

ug Microgram

ug/wipe microgram per wipe

ORGANICS LABORATORY SERVICES



Company NVL Field Services Division Address 4708 Aurora Ave. N. Seattle, WA 98103						
Project Manager Mr. Munaf Khan Phone (206) 547-0100 Cell: (b) (6)				Due Date 2/3/2015 Time 12:00 PM Email munaf.k@nvllabs.com		
Project	Name/I	Number: 2012-494	Project Loca	ation: 3100 Airport Way South, Seattle, WA 98134		
•	gory Qu ode OF	antitative analysis RG-03 80	82 PCB Aroclors <wipe< th=""><th>></th><th></th></wipe<>	>		
Total	Numb	er of Samples	3	Rush Samples		
La	b ID	Sample ID	Description		A/R	
1 150	008188	12315-PCB A			Α	
2 150	008189	12315-PCB B			Α	
3 150	008190	12315-PCB C			Α	

	Print Name	Signature	Company	Date	Time
Sampled by	Client				
Relinquished by	Client				
Office Use Only	Print Name	Signature	Company	Date	Time
Received by	Maxwell Ravmond		NVL	1/27/15	1200
Analyzed by	Evelyn Ahuly	Edone	NVL	1/29/15	14:30
Results Called by				1	
☐ Faxed ☐ Emailed					
Special				II.	
Instructions:					

Entered By: Shaista Khan

Date: 1/27/2015

Time: 1:08 PM

1 of 1

4708 Aurora Ave North, Seattle, WA 98103 | p 206.547.0100 | f 206.634.1936 | www.nvllabs.com



Polychlorinated Biphenyls by Gas Chromatography

Client SDG Number Date Reported Project Number Location	NVL Field Services Division 1501497.00 02/02/2015 2012-494 3100 Airport Way South Seattle, WA 98134	Samples Received* Analyzed By Samples Analyzed* Analysis Method Preparation Method	3 Evelyn Ahulu 3 8082A 3546PR (PCB) * for this test only		
Sample Number	r 12315-PCB A	Received	01/27/2015		
Lab Sample ID	15008188	Matrix	Dust Wipe		
Initial Sample Size	e 100 cm2	Units of Result	ug/100cm2		
Analyte		RL	Final Result Analysis D	ate	
Aroclor-1016		0.050	< 0.050 01/29/2015		
Aroclor-1221		0.050	< 0.050 01/29/2015		
Aroclor-1232		0.050	< 0.050 01/29/2015		
Aroclor-1242		0.050	< 0.050 01/29/2015		
Aroclor-1248		0.050	< 0.050 01/29/2015		
Aroclor-1254		0.050	8 01/29/2015		
Aroclor-1260		0.050	5.2 01/29/2015		
PCBs, Total Comments: BLDG 10-20	00-North Window sill	0.050	13.2 01/29/2015		
Sample Number	r 12315-PCB B	Received	01/27/2015		
Lab Sample ID	15008189	Matrix	Dust Wipe		
Initial Sample Size	e 100 cm2	Units of Result	ug/100cm2		
Analyte		RL	Final Result Analysis D	ate	
Aroclor-1016		0.050	< 0.050 01/29/2015		
Aroclor-1221		0.050	< 0.050 01/29/2015		
Aroclor-1232		0.050	< 0.050 01/29/2015		
Aroclor-1242		0.050	< 0.050 01/29/2015		
Aroclor-1248		0.050	< 0.050 01/29/2015		
Aroclor-1254		0.050	2.6 01/29/2015		
Aroclor-1260		0.050	2.1 01/29/2015		
PCBs, Total		0.050	4.7 01/29/2015		

Phone: 206.547.0100 | Fax: 206.634.1936 | Toll Free: 1.888.NVL.LABS (685.5227) 4708 Aurora Avenue North | Seattle, WA 98103

Comments: BLDG 10-200- South Window Sill



Polychlorinated Biphenyls by Gas Chromatography

Sample Number 12315-PCB C		Received	01/27/2015
Lab Sample ID	ID 15008190 Matrix Dust Wipe		Dust Wipe
Initial Sample Size	100 cm2	Units of Result	ug/100cm2
Analyte		RL	Final Result Analysis Date
Aroclor-1016		0.050	< 0.050 01/29/2015
Aroclor-1221		0.050	< 0.050 01/29/2015
Aroclor-1232	Aroclor-1232		< 0.050 01/29/2015
Aroclor-1242		0.050	< 0.050 01/29/2015
Aroclor-1248		0.050	< 0.050 01/29/2015
Aroclor-1254		0.050	< 0.050 01/29/2015
Aroclor-1260		0.050	< 0.050 01/29/2015
PCBs, Total		0.050	<0.05 01/29/2015

Comments: Field Blank.Result is based on an assumption that 100cm2 area was used.



Phone: 206 547-0100 Fax: 206 634-1936

Quality Control Results

Project Number:	2012-494			SDG Nu	ımber: Manager:		501497 Iunaf Kha	n		
								"		
QC Batch(es):	Q250			-	s Method:	808	32A			
QC Batch Method:	3546PR (PCB)			Analysis De	scription:		•		henyls by Ga	as
Preparation Date:	01/29/2015					Chr	omatogra	phy		
Blank: BLK-1501497	7									
	Blank				RL		Control			
Analyte	Result	Units	DF				Limit			Qualifiers
Aroclor-1016	ND	ug/wipe	1		0.050		0.05			
Aroclor-1221	ND	ug/wipe	1		0.050		0.05			
Aroclor-1232	ND	ug/wipe	1		0.050		0.05			
Aroclor-1242	ND	ug/wipe	1		0.050		0.05			
Aroclor-1248	ND	ug/wipe	1		0.050		0.05			
Aroclor-1254	ND	ug/wipe	1		0.050		0.05			
Aroclor-1260	ND	ug/wipe	1		0.050		0.05			
PCBs, Total	ND	ug/wipe	1		0.050		0.05			
Surrogates:						% Rec				
Tetrachloro-m-xylene			1			87	40-140			
Decachlorobiphenyl			1			83	40-140			
Lab Control Sample	: MSPK-1501497									
	Blank Spike			Spike			% Rec			
Analyte	Result	Units	DF	Conc.		% Rec	Limits			Qualifiers
Aroclor-1254 Surrogates:	0.172	ug/wipe	1	0.200		86	40-140			
Tetrachloro-m-xylene			1			76	40-140			
Decachlorobiphenyl			1			91	40-140			
Lab Control Sample	: LCS-1501497									
Lab Control Sample	Duplicate: LCS D	up-150149	7							
	Blank Spike			Spike						
Analyte	Result	Units	DF	Conc.		% Rec	Limits	RPD	RPD Limit	Qualifiers
Aroclor-1016	0.2	ug/wipe	1	0.200		100	40-140			
	0.184			0.200		92	40-140	8	50	
Aroclor-1260	0.15	ug/wipe	1	0.200		75	40-140	0.1	5 0	
Surrogates:	0.206			0.200		103	40-140	31	50	
Surrogates:			4			00	40 440			
Tetrachloro-m-xylene			1			83 84	40-140 40-140			
Decachlorobiphenyl			1			84 86	40-140 40-140			
Decacilioropiphenyl			ı			89	40-140			

Surrogate Recovery Summary Report

Client NVL Field Services Division	<u>n</u>	SDG Number	r <u>1501497</u>	
Project 2012-494				
Customer Sample ID	Lab Sample ID	Analyte	Recovery	Limits
12315-PCB A	15008188	Decachlorobiphenyl	76%	40-140
12315-PCB A	15008188	Tetrachloro-m-xylene	75%	40-140
12315-PCB B	15008189	Decachlorobiphenyl	81%	40-140
12315-PCB B	15008189	Tetrachloro-m-xylene	73%	40-140
12315-PCB C	15008190	Decachlorobiphenyl	70%	40-140
12315-PCB C	15008190	Tetrachloro-m-xylene	65%	40-140
BLK-1501497	BLK-1501497	Decachlorobiphenyl	83%	40-140
BLK-1501497	BLK-1501497	Tetrachloro-m-xylene	87%	40-140
LCS Dup-1501497	LCS Dup-1501497	Decachlorobiphenyl	89%	40-140
LCS Dup-1501497	LCS Dup-1501497	Tetrachloro-m-xylene	84%	40-140
LCS-1501497	LCS-1501497	Decachlorobiphenyl	86%	40-140
LCS-1501497	LCS-1501497	Tetrachloro-m-xylene	83%	40-140
MSPK-1501497	MSPK-1501497	Decachlorobiphenyl	91%	40-140
MSPK-1501497	MSPK-1501497	Tetrachloro-m-xylene	76%	40-140

^{*} Recovery outside limits

INITIAL AND CONTINUING CALIBRATION VERIFICATION

SDG No: <u>1501497</u> Contract: <u>N/A</u>

Determination: 8082 PCB Aroclors <Wipe>

Run	Sample	Source	Analyzed	Analyte	True	Found	Unit	% Rec	Limits
R000243	CCV1 1016-1260	PCB_2014-2-6	01/29/2015	Aroclor-1016	0.1	0.1	ug/mL	100	80-120
		PCB_2014-2-6	01/29/2015	Aroclor-1260	0.1	0.1	ug/mL	100	80-120
	CCV1 1254	PCB_2014-2-7	01/29/2015	Aroclor-1254	0.1	0.1	ug/mL	100	80-120
	CCV2 1016-1260	PCB_2014-2-6	01/29/2015	Aroclor-1016	0.1	0.106	ug/mL	106	80-120
		PCB_2014-2-6	01/29/2015	Aroclor-1260	0.1	0.106	ug/mL	106	80-120
	CCV2 1254	PCB_2014-2-7	01/29/2015	Aroclor-1254	0.1	0.1	ug/mL	100	80-120

RCLLC 0004920

[%] Rec = Percent recovery

^{* =} Percent recovery not within control limits

4708 Aurora Ave N, Seattle, WA 98103

CHAIN of CUSTODY SAMPLE LOG

1501497

p 206.547.	.0100 †20	06.634.1936	www.nvllabs.c	om						
	Client	NVL Labo	ratories Inc			NVL Batch I				
			ora Ave N			Client Job I	Number 2012	2-494		
	_		VA 98103			Total S	amples	3		
Project N	∕lanager <u>N</u>	/lunaf Kh	an			Turn Around	l Time 🗌 1 Hr	6 Hrs	☐ 3 Days [☐ 10 Days
			ort Way South	1			2 Hrs	s	☐ 4 Days	
,			VA 98134						r TAT less that	n 24 Hrs
						Email a	ddress			
	Phone: (206) 447	-0263 Fax	: (206) 44	17-0299					
Asb	estos Air	PCM	(NIOSH 7400)	TEM (NIOSH 7402)	TEM (AHE	RA) 🗌 TEM	(EPA Level	II) 🗌 Othe	r
Asbe	estos Bull	k 🗌 PLM	(EPA/600/R-93	/116) 📋	PLM (EPA Poi	nt Count) 🔲 F	LM (EPA Gra	vimetry)	TEM BULK	
☐ Mold	d/Fungus	_ ☐ Mold	Air	ulk 🔲	Rotometer Ca	libration				
☐ TCLI ☐ Cr 6	l Metals P er Types	Det. Lin	(ppm) Air F (ppm) Drin A (ppb) Dus glass Nuisa	Filter king water t/wipe (Are ance Dust	Paint C		admium (Cd)	<u></u>	ium (Cr Cb)	er Metals All 3 copper (Cu) lickel (Ni) inc (Zn)
	nalysis	Silica		irable Dust						
Conditio	on of Pack	age: 🔲	Good L Dam	aged (no s	pillage) ∐ Se	evere damage (spillage)			
Seq. #	Lab ID		Client Sampl	e Number	Comments					AREAVR
1			12315	-PCBA	BUDG.	10-20	G-NO27	4 WIN	JOH 5/4	LUOCH
2			i.	IC B	BLDG	10-20	0 - SOUTA	1 WIND	OW SILL	U
3			U	11 C	FIELD	BLANK	_			-
4										
5										
6									1	
7						**				
8										
9										
10										
11										
12										
13			· · · ·							
14										
15										
		Print B	olow	Sian Belo	m (//	1	`omnanı		Data	Time
9	Sampled b	100000000000000000000000000000000000000	E CEONAR	h Sidir Bei	de -	//	Ompany		24-1	Time
	quished b		CLEONAR	3.00	Lev		NVL		1-27-6	1200
	eceived b	11	(2	-	1	5	M		1/27/1-	1200
	nalyzed b		in Ahuln	508	dalla		NVL		170/15	14.26
	s Called b		1.1 (Levelo.)		Ser levi		1446	*	11-29/10	11130
	s Faxed b									
	Instructi report to		less requested $R \subset of$	_				-	sis.	